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Substitute Form PTO-1449

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U.S. Department of Commerce Patent and Trademark Office Attorney's Docket No. 14603-012US1

Application No. 10/526,097

Information Disclosure Statement by Applicant (Use several sheets if necessary) Applicant
Thomas Mueller

Filing Date
September 7, 2005

Group Art Unit 2858

(37 CFR §1.98(b))

**U.S. Patent Documents** Publication Filing Date Document Examiner Desig. Number Date Patentee Class Subclass If Appropriate Initial ID AAAB ACAD ΑE AF AG AHΑI ΑJ ΑK

	Foreign Patent Documents or Published Foreign Patent Applications							
Examiner	Desig.	Document	Publication	Country or			Transla	
Initial	ID	Number	Date	Patent Office	Class	Subclass	Yes	:'Nöx
/AD/	AL .	07-022477	01/24/1995	Japan	·		Abstract	
	AM							
	AN							
	AO							
	AP							

Other Documents (include Author, Title, Date, and Place of Publication)						
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Examiner Signature	/Anjan Deb/ (06/20/2007)	Date Considered
EXAMINER: Initials ci	tation considered. Draw line through citation if n	ot in conformance and not considered. Include copy of this form with
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BT01 Bec'd PCT/PTO FEB 2005

Substitute Form PTO-1449 (Modified)

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Examiner Initial	Desig. ID	Document
	AU	

Examiner Signature /Anjan Deb/ (06/20/2007)	Date Considered
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